## Application/Control No. Applicant(s)/Patent Under Reexamination 09/873,786 YEN ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2155 Oanh L. Duong

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
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	J	US-			
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## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 01/22731 A1	.03-2001		Barrett et al.	H04N 7/16
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	Р					
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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